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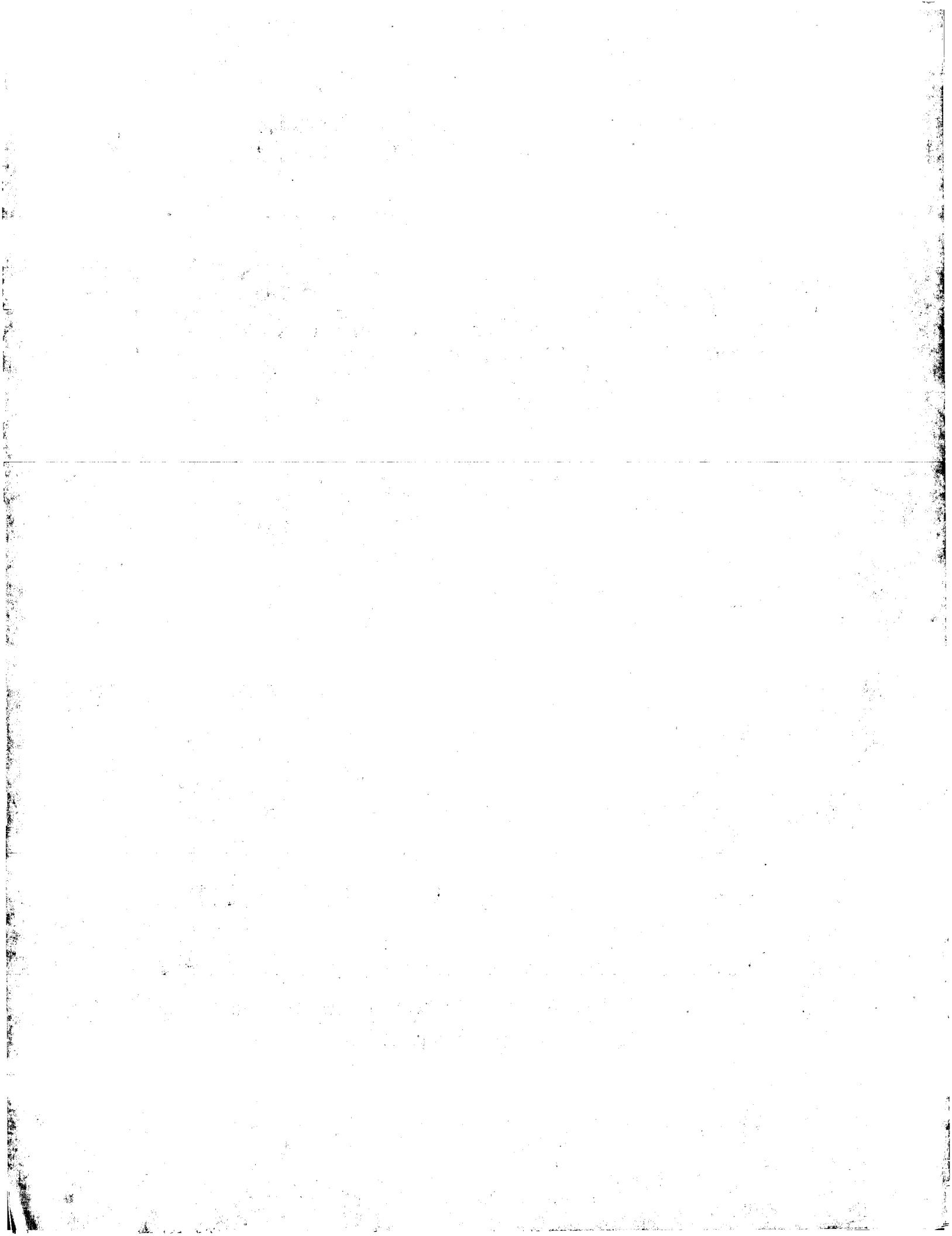
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(54) Title: PROCESS CHAMBER ASSEMBLY WITH REFLECTIVE HOT PLATE AND PIVOTING LID

(57) Abstract: A hot plate assembly includes a base plate, a lid and a housing positioned between the base plate and the lid. The housing, lid and base plate form a process chamber. An insulator is positioned adjacent to the base plate in the process chamber. An air gap is formed at least partially between a bottom surface of the insulator and a top surface of the base plate. A hot plate is positioned adjacent to the insulator in the process chamber. At least a first reflective member is positioned between the hot plate and the insulator.

**PROCESS CHAMBER ASSEMBLY WITH
REFLECTIVE HOT PLATE AND PIVOTING LID**

BACKGROUND OF THE INVENTION

5

Field of the Invention:

This invention relates in general to the field of wafer processing equipment, and more particularly to bake modules.

10

Discussion of Related Art:

Temperature uniformity across a wafer surface is an important factor in many integrated circuit fabrication steps since rate processes used in fabrication are generally temperature dependent. In particular processes, thermal non-uniformity can adversely effect a circuit element's critical dimension size by enlarging it relative to a design goal. Thus, as trends toward smaller integrated circuit critical dimensions continue, temperature uniformity requirements for wafer thermal management systems will become increasingly stringent.

For example, as compared to earlier standards, current temperature uniformity requirements of 0.1°C across a several hundred millimeters diameter wafer represent a 50% increase in temperature uniformity. Wafer heating units must be able to achieve such temperature uniformity figures of merit over a wide range of process operating temperatures, typically from about 90°C to several hundred degrees Celsius, and in a manner consistent from wafer-to-wafer.

Thus, due to the limitations of related art, there is a need for methods of efficient, rapid, controllable and uniform thermal management over a wide temperature range. Further, there is a need for an apparatus that provides the desired high performance during both steady state and transient conditions and that is very suitable for easy use within a manufacturing setting. There is a further need for a process module assembly with a lid that is rotatable without

being removed from the process module to permit access to an interior surface of the lid.

SUMMARY OF THE INVENTION

5 Accordingly, an object of the present invention is to provide a hot plate utilized in a process module of semiconductor manufacturing equipment that creates thermal uniformity across a wafer positioned in close proximity to a surface of hot plate.

10 Another object of the present invention is to provide a hot plate utilized in a process module of semiconductor manufacturing equipment that has thermal uniformity across its top surface.

A further object of the present invention is to provide a hot plate assembly for a bake module that minimizes thermal contamination to its surrounding environment.

15 Yet another object of the present invention is to provide a hot plate assembly for a bake module that includes a lid, a base plate, a hot plate, an insulator and reflective surfaces.

A further object of the present invention is to provide a hot plate that minimizes thermal contamination to its associated base plate.

20 Another object of the present invention is to provide a hot plate assembly that minimizes down time for servicing of the bake module.

An object of the present invention is to provide a hot plate assembly that includes reflective surfaces to contain radiative heat losses from the hot plate.

25 A further object of the present invention is to provide a hot plate assembly that includes air gaps to control convective heat losses from the hot plate.

Yet another object of the present invention is to provide a hot plate assembly for a bake module that includes a lid, a base plate, a hot plate, an insulator, reflective surfaces and air gaps.

30 A further object of the present invention is to provide a hot plate assembly with air gaps between the insulator and the hot plate, and the hot plate and the lid.

Yet another object of the present invention is to provide a process module assembly with a lid that is rotatable without being removed from the process module in order to permit access to an interior surface of the lid.

Another object of the present invention is to provide a process module 5 assembly with a lid that has an interior surface which can be cleaned without removing the lid from the process module assembly.

A further object of the present invention is to provide a process module assembly that includes a lid supported at a single pivot point.

These and other objects of the present invention are achieved in a hot 10 plate assembly that includes a base plate, a lid and a housing positioned between the base plate and the lid. The housing, lid and base plate form a process chamber. An insulator is positioned adjacent to the base plate in the process chamber. An air gap is formed at least partially between a bottom surface of the insulator and a top surface of the base plate. A hot plate is positioned adjacent 15 to the insulator in the process chamber. At least a first reflective member is positioned between the hot plate and the insulator.

In another embodiment, the present invention a process module assembly includes a base plate, a lid and a housing positioned between the base plate and the lid. The housing, lid and base plate form a process chamber. A lid 20 sealing member is positioned between the housing and the lid. A single lid support is provided with a longitudinal axis that extends from the base plate to the lid. The lid is sufficiently rotatable about the longitudinal axis to permit access to an interior surface of the lid without removal of the lid from the single lid support.

25

BRIEF DESCRIPTION OF THE DRAWINGS

Figure 1 is a perspective view of one embodiment of a process module of the present invention with a lid that is rotatable about a single pivot point..

Figure 2 is a cross-sectional view of the Figure 1 process module.

30 Figure 3 is a top perspective view of the Figure 1 process module with the lid rotated about a chamber lid pivot point to allow for cleaning of an interior of the lid.

Figure 4 is an exploded view of one embodiment of the Figure 1 process module.

Figure 5 is a cross-sectional view of a portion of the Figure 4 process module.

5 Figure 6 is a full cross-sectional view of the Figure 4 process module.

DETAILED DESCRIPTION

One embodiment of the present invention is a process module assembly 10 for use in semiconductor manufacturing equipment. Suitable process 10 modules include but are not limited to a bake module. As illustrated in Figure 1, assembly 10 includes a lid 12, a base plate 14 and a housing 16. Lid 12, base plate 14 and housing 16 define a process chamber.

Referring now to Figures 2 and 3, lid 12 is supported in a horizontal plane by a horizontal guide 18 and a vertical shaft 20 at a lid pivot point 22.

15 Shaft 20 is supported in a bearing block 22 with two bushings 24. Together guide 22 and bushings 24 provide support for lid 12. Guide 22 is rigidly attached to a mounted block 26 located on base plate 14.

Lid's 12 open and close motion can be accomplished with a pneumatic cylinder 28, or other suitable mechanical structure, attached between bearing 20 block 22 and base plate 14. In normal operation lid 12 is constrained from rotating with a suitable device including but not limited to a retractable spring plunger 30 located on bearing block 22. In the up position, cylinder 28 is in its fully extended position. Lid 12 is supported in the horizontal plane by the reaction forces of horizontal guide 22 and bushings 24. Lid 12 can be cleaned 25 or serviced in the "up" or open position. To rotate lid 12 spring plunger 30 is retracted. When spring plunger 30 is retracted lid 12 can be rotated to a position allowing access to clean an internal lid surfaces 32 which can include a shower head or other assembly that delivers a fluidic medium to the chamber..

Bushings 24 allow lid 12 to be rotated about a vertical pivot axis. 30 Substantially constant contact with horizontal guide 22 maintains lid 12 in a horizontal plane. Retracting spring plunger 30 and rotation of lid 12 is accomplished without removing or disassembling assembly 12. A flexible

process gas tube 34 allows movement with lid 12 while remaining fixed (connected) at the opposite end. In the "down" or closed position, a chamber vacuum seal, such as O-ring 36, provides a vacuum tight boundary and sealing surface of the process chamber. A controlled clearance between the lid support shaft and the bushings allows the sealing surface of the lid to lie parallel a top of housing 16. Additionally, the design allows for a small amount of vertical axis relative motion between the lid support shaft and bearing block due to variations in pneumatic cylinder stroke length and compression of the vacuum seal.

Referring now to Figures 4 and 5, process module assembly 10 is a bake module that includes an insulator 38, one or more reflective members 40, a hot plate 42 and housing 16. Reflective members 40 can have plate-type geometric configurations. Housing 16 has a diameter larger than the diameters of hot plate 42 and insulator 38, and a height that is approximately equal to the height of insulator 38 and hot plate 42. Lid 12 can include a shower heat 44. Base plate 14 can include an exhaust port and an assembly to move lid 12, as described in Figures 2 and 3. Insulator 38 is positioned on base plate 14 in a manner to create a first air gap 46. First air gap 46 creates a conductive resistance layer between base plate 14 and the remaining elements of assembly 10. The diameter of first air gap 46 can be smaller than the diameter of insulator 38.

Insulator 38 has a top surface with a recess 48. Recess 48 is dimensioned to receive one or more reflective members 40. As illustrated in Figure 4, three reflective members 40 are included. It will be appreciated that the present invention can include one reflective member 40, or any number of reflective members 40. An air gap 50 is formed between a top surface of insulator 38 and the lower most reflective member 40. Air gap 50 creates a conductive resistance layer. Air gaps are also formed between adjacent reflective members 40 to once again create conductive resistance layers.

The top surfaces of reflective members 40 have high thermal reflectivity and low thermal absorptivity characteristics. The diameters of reflective members 40 are slightly smaller than the diameter of hot plate 42.

An air gap 52 is formed between housing 16 and insulator 38 and hot plate 42. Hot gases surrounding hot plate 42 are removed by traveling from gap 52 and then through exhaust ports 54 that are formed in insulator 38.

Grooves 56 and 58 are formed in top and bottom surfaces of housing 5 16. O-rings 60 and 36 are received in grooves 62 and 64. O-ring 60 provides a seal between housing 16 and base plate 14, while O-ring 36 creates a seal between housing 16 and lid 12.

Process gases can be introduced to assembly 10 through a gas conduit 66. Shower head 44 receives gases from gas conduit 66 and injects the gases 10 onto a top surface of a wafer positioned adjacent to hot plate 42.

It will be readily apparent to those skilled in the art that this invention is not limited to the embodiments described above. Different configurations and embodiments can be developed without departing from the scope of the invention and are intended to be included within the scope of the claims set 15 forth below.

CLAIMS

What is claimed is:

- 5 1. A hot plate assembly, comprising:
 a base plate;
 a lid;
 a housing positioned between the base plate and the lid, the
 housing lid and base plate forming a process chamber;
10 an insulator positioned adjacent to the base plate in the process
 chamber with an air gap formed at least partially between a bottom surface of
 the insulator and a top surface of the base plate;
 a hot plate positioned adjacent to the insulator in the process
 chamber; and
15 at least a first reflective member positioned between the hot plate
 and the insulator.
2. The assembly of claim 1, further comprising:
 a first fluid delivery member coupled to the lid, the first fluid
 delivery member being positioned in the process chamber when the lid is sealed
20 to the housing.
3. The assembly of claim 2, wherein the first fluid delivery member
 is a shower head.
4. The assembly of claim 2, further comprising:
 a flexible second fluid delivery member extending from an exterior of
25 the lead and coupled to the first fluid delivery member.
5. The assembly of claim 4, wherein the flexible second fluid
 delivery member is made of a pliable material.
6. The assembly of claim 1, wherein at least a portion of the
 insulator is distanced from the base plate to create a first air gap in the process
30 chamber.

7. The assembly of claim 1, wherein at least a portion of the insulator is sufficiently distanced from the base plate to create a conductive resistance layer between the base plate and the hot plate.
8. The assembly of claim 6, wherein the diameter of the first air gap is less than a diameter of the insulator.
9. The assembly of claim 1, wherein the insulator has a top surface that includes a recess.
10. The assembly of claim 9, wherein the first reflective member is at least partially positioned in the recess.
10. The assembly of claim 1, wherein at least a portion of the first reflective member is sufficiently distanced from the insulator to create an air gap between the insulator and the first reflective member.
12. The assembly of claim 1, wherein at least a portion of the first reflective member is sufficiently distanced from the insulator to create a conductive resistance layer between the first reflective member and the insulator.
13. The assembly of claim 1, further comprising:
a second reflective member positioned adjacent to the first reflective member.
20. The assembly of claim 13, wherein at least portions of the first and second reflective members are sufficiently distanced to create an air gap between the first and second reflective members.
25. The assembly of claim 13, wherein each of the first and second reflective members has a top surface facing the lid and a bottom surface facing the base plate.
16. The assembly of claim 15, wherein each top surface of the first and second reflective members has a high thermal reflectivity.
17. The assembly of claim 16, wherein each top surface of the first and second reflective members has a low thermal absorptivity characteristic.
30. 18. The assembly of claim 13, wherein each of the first and second reflective members has a diameter than is smaller than a diameter of the hot plate.

19. The assembly of claim 1, further comprising:
an O-ring that creates a seal between the housing and the lid.
20. A process module assembly, comprising:
a base plate;
5 a lid;
a housing positioned between the base plate and the lid, the housing lid and base plate forming a process chamber;
a lid sealing member positioned between the housing and the lid;
and
10 a single lid support with a longitudinal axis that extends from the base plate to the lid, wherein the lid is sufficiently rotatable about the longitudinal axis to permit access to an interior surface of the lid without removal of the lid from the single lid support.
21. The assembly of claim 20, wherein the single lid support
15 includes an elongated guide and a bearing member.
22. The assembly of claim 21, wherein the bearing member includes at least one bushing.
23. The assembly of claim 21, wherein the elongated guide is rigidly coupled to the base plate.
- 20 24. The assembly of claim 20, wherein the single lid support includes a pneumatic cylinder.
- 25 25. The assembly of claim 20, further comprising:
a lid restraining member, the lid restraining member minimizing rotational movement of the lid.
26. The assembly of claim 25, wherein the lid restraining member includes a retractable spring plunger coupled to the bearing member.
27. The assembly of claim 20, further comprising:
30 an insulator positioned adjacent to the base plate in the process chamber with an air gap formed at least partially between a bottom surface of the insulator and a top surface of the base plate;
a hot plate positioned adjacent to the insulator in the process chamber; and

at least a first reflective member positioned between the hot plate and the insulator.

28. The assembly of claim 27, further comprising:
a first fluid delivery member coupled to the lid, the first fluid delivery member being positioned in the process chamber when the lid is sealed to the housing.

5 29. The assembly of claim 28, wherein the first fluid delivery member is a shower head.

10 30. The assembly of claim 28, further comprising:
a flexible second fluid delivery member extending from an exterior of the lead and coupled to the first fluid delivery member.

31. The assembly of claim 30, wherein the flexible second fluid delivery member is made of a pliable material.

15 32. The assembly of claim 27, wherein at least a portion of the insulator is distanced from the base plate to create a first air gap in the process chamber.

33. The assembly of claim 27, wherein at least a portion of the insulator is sufficiently distanced from the base plate to create a conductive resistance layer between the base plate and the hot plate.

20 34. The assembly of claim 32, wherein the diameter of the first air gap is less than a diameter of the insulator.

35. The assembly of claim 27, wherein the insulator has a top surface that includes a recess.

25 36. The assembly of claim 35, wherein the first reflective member is at least partially positioned in the recess.

37. The assembly of claim 27, wherein at least a portion of the first reflective member is sufficiently distanced from the insulator to create an air gap between the insulator and the first reflective member.

30 38. The assembly of claim 27, wherein at least a portion of the first reflective member is sufficiently distanced from the insulator to create a conductive resistance layer between the first reflective member and the insulator.

39. The assembly of claim 27, further comprising:
a second reflective member positioned adjacent to the first
reflective member.

40. The assembly of claim 39, wherein at least portions of the first
5 and second reflective members are sufficiently distanced to create an air gap
between the first and second reflective members.

41. The assembly of claim 39, wherein each of the first and second
reflective members has a top surface facing the lid and a bottom surface facing
the base plate.

10 42. The assembly of claim 41, wherein each top surface of the first
and second reflective members has a high thermal reflectivity.

43. The assembly of claim 42, wherein each top surface of the first
and second reflective members has a low thermal absorptivity characteristic.

15 44. The assembly of claim 39, wherein each of the first and second
reflective members has a diameter than is smaller than a diameter of the hot
plate.

1/6

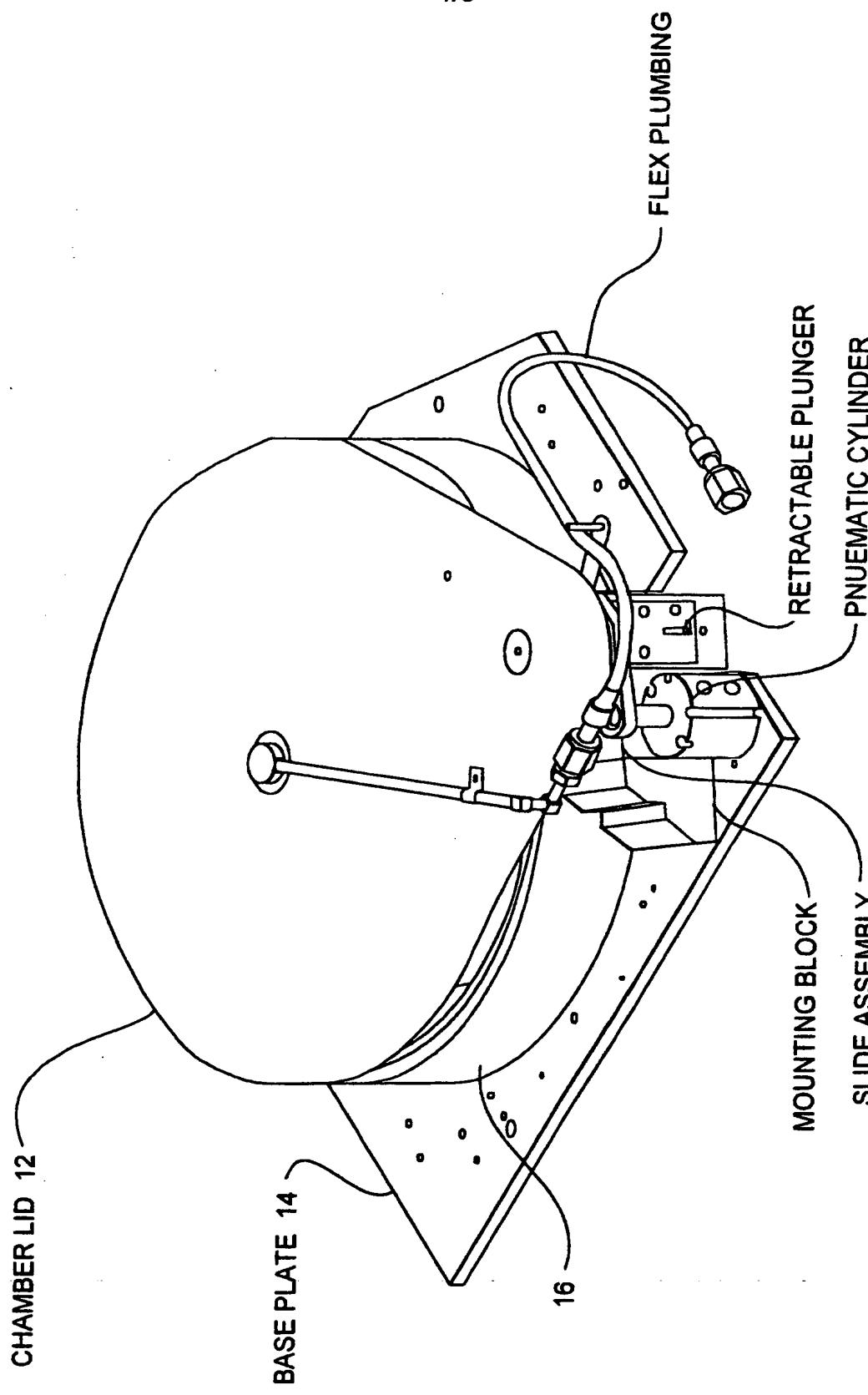


FIG. 1

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ISA/EP

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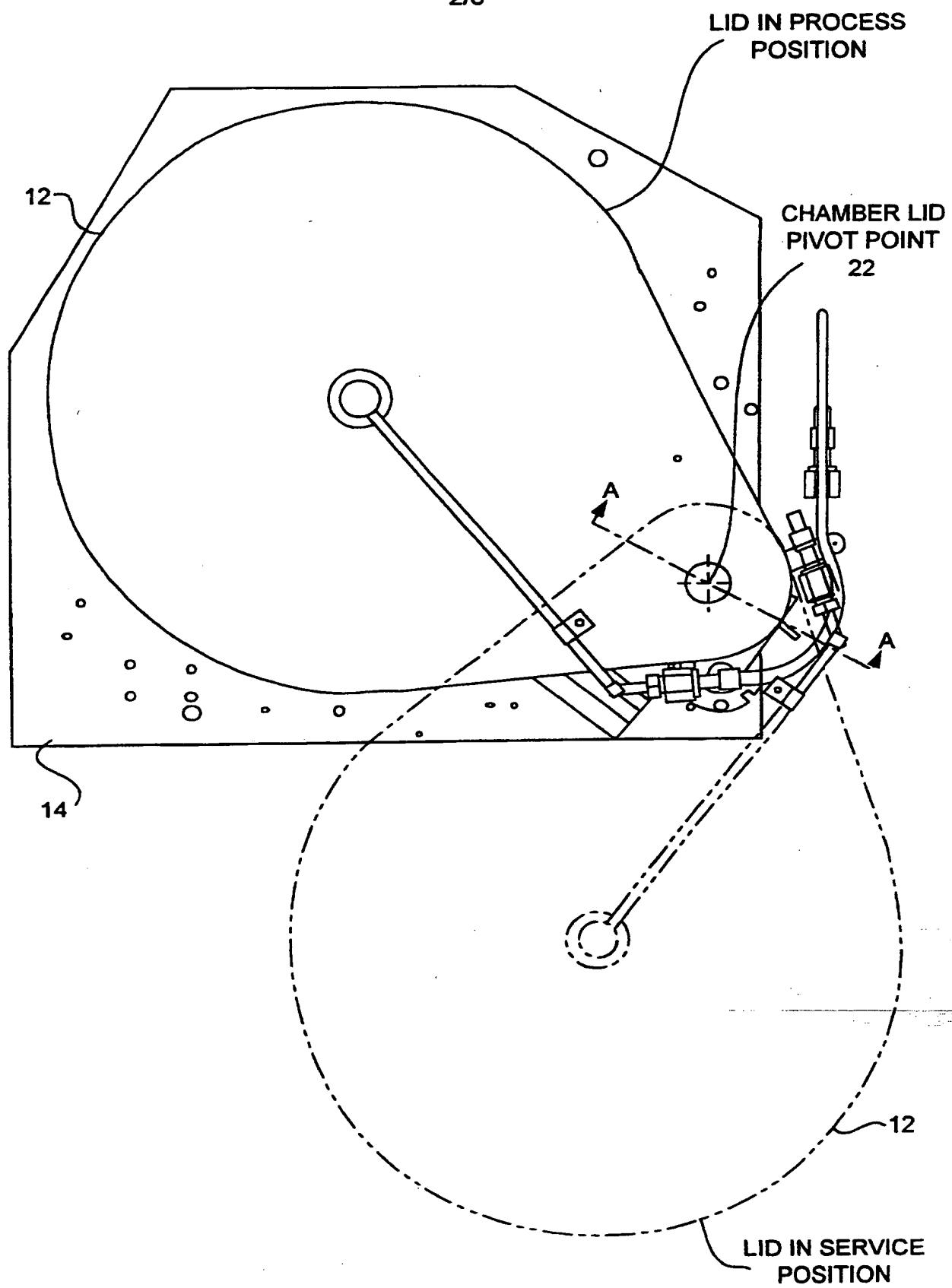


FIG. 2

RECTIFIED SHEET (RULE 91)
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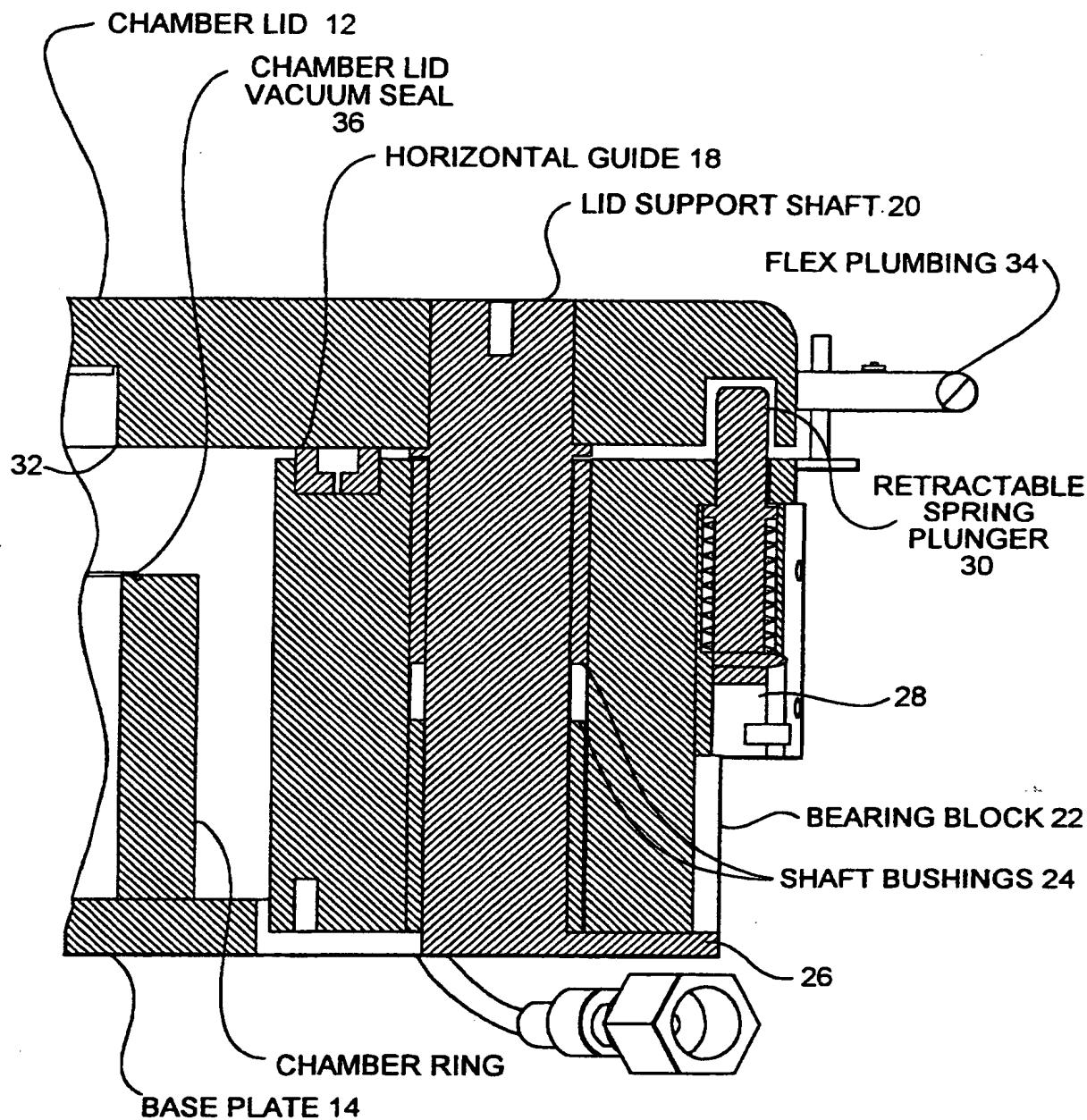


FIG. 3

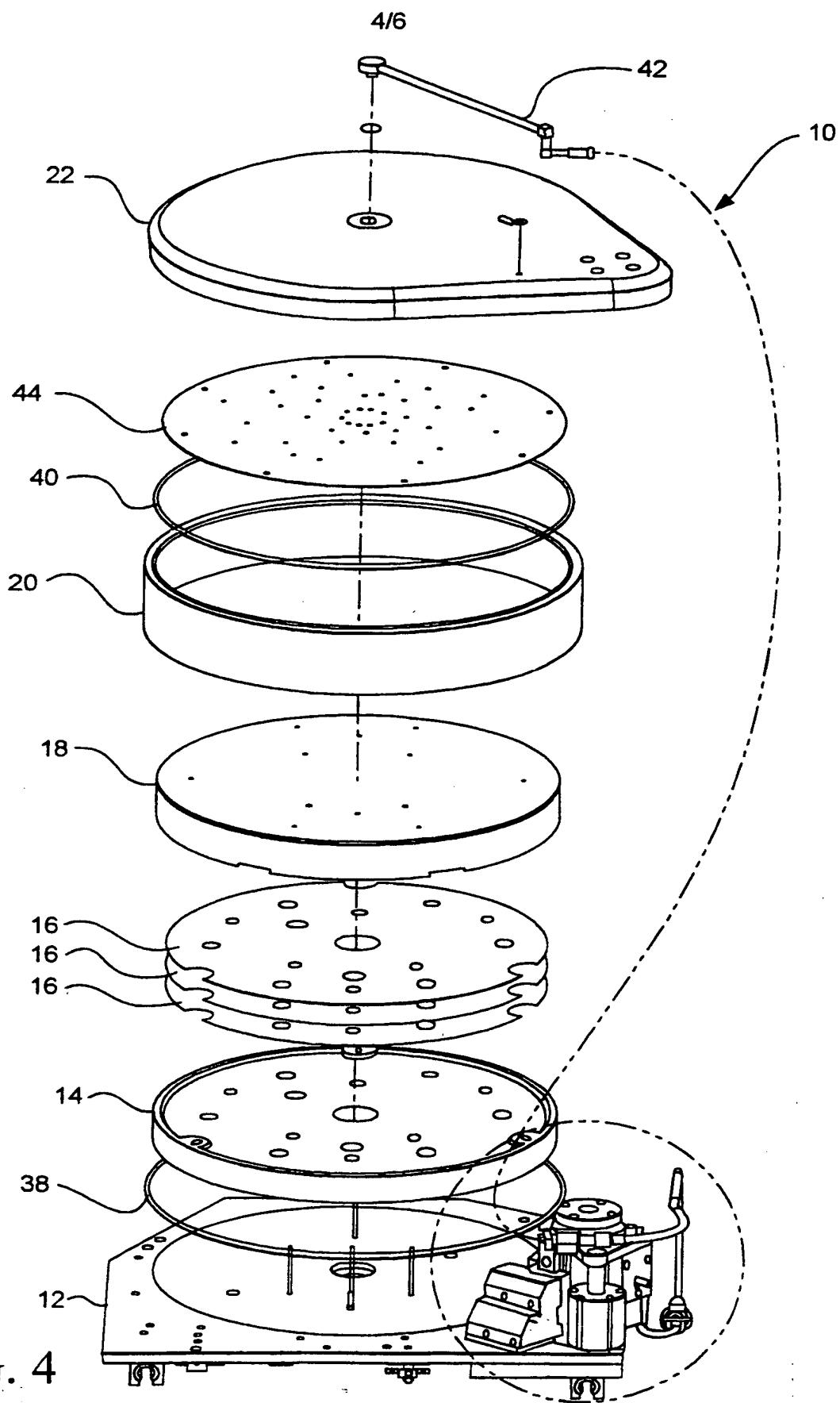


FIG. 4

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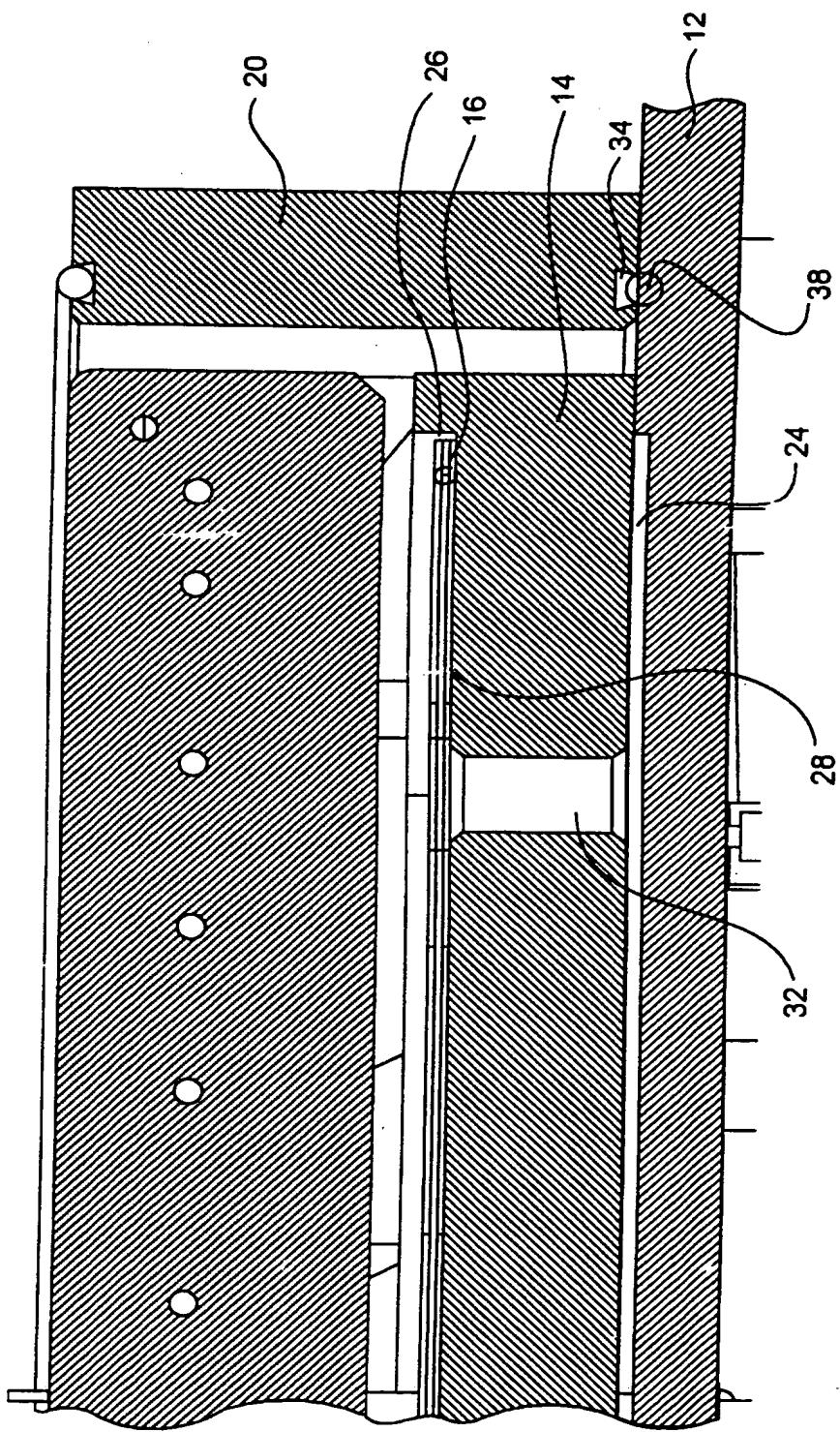


FIG. 5

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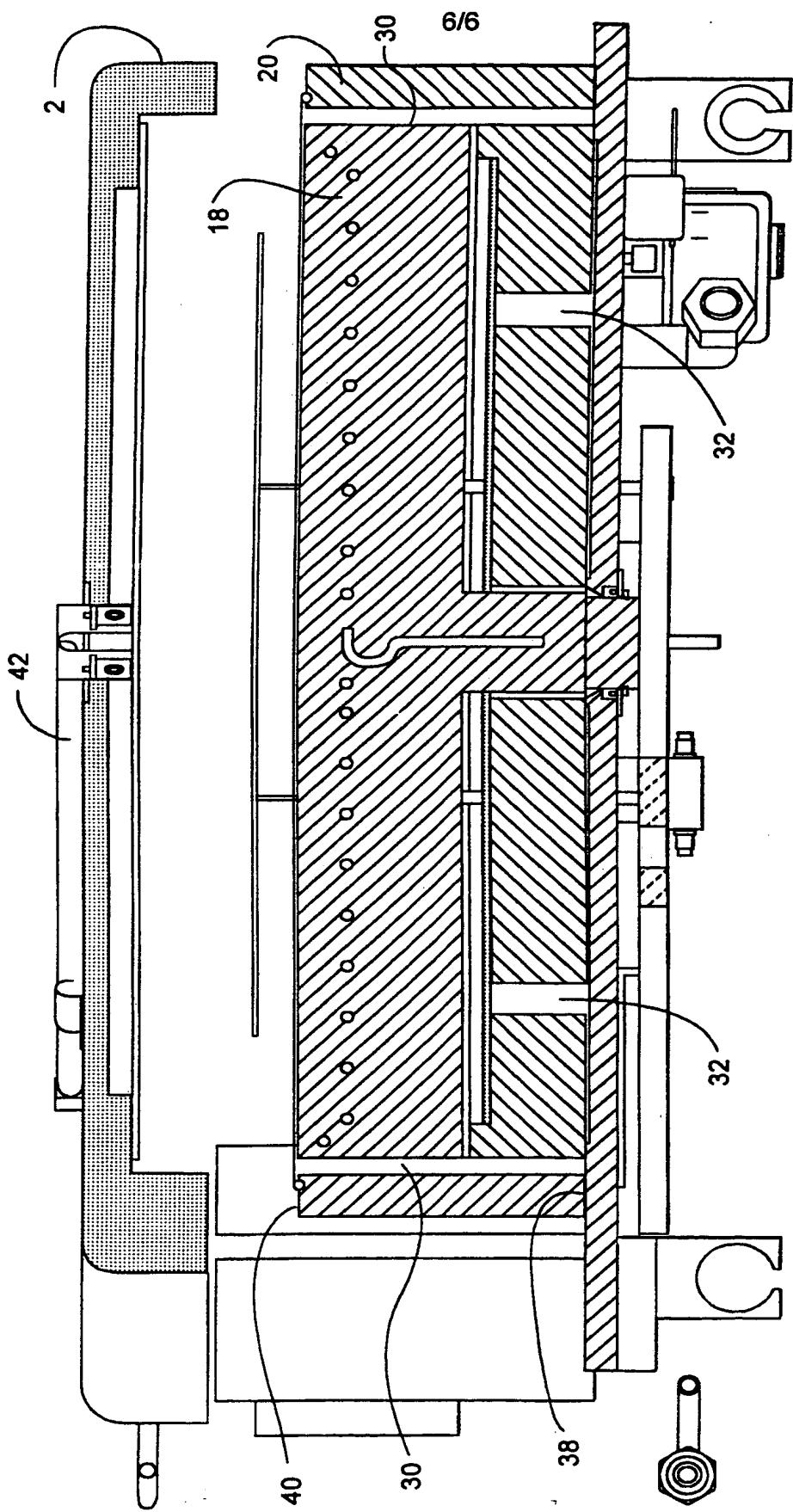


FIG. 6



DK, DM, DZ, EE, ES, FI, GB, GD, GE, GH, GM, HR, HU, ID, IL, IN, IS, JP, KE, KG, KP, KR, KZ, LC, LK, LR, LS, LT, LU, LV, MA, MD, MG, MK, MN, MW, MX, MZ, NO, NZ, PL, PT, RO, RU, SD, SE, SG, SI, SK, SL, TJ, TM, TR, TT, TZ, UA, UG, US, UZ, VN, YU, ZA, ZW.

(84) **Designated States (regional):** ARIPO patent (GH, GM, KE, LS, MW, MZ, SD, SL, SZ, TZ, UG, ZW), Eurasian patent (AM, AZ, BY, KG, KZ, MD, RU, TJ, TM), European patent (AT, BE, CH, CY, DE, DK, ES, FI, FR, GB, GR, IE, IT, LU, MC, NL, PT, SE), OAPI patent (BF, BJ, CF, CG, CI, CM, GA, GN, GW, ML, MR, NE, SN, TD, TG).

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INTERNATIONAL SEARCH REPORT

International Application No
PCT/US 00/16635

A. CLASSIFICATION OF SUBJECT MATTER
IPC 7 H01L21/00

According to International Patent Classification (IPC) or to both national classification and IPC

B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)
IPC 7 H01L B65D F16J

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

Electronic data base consulted during the international search (name of data base and, where practical, search terms used)

EPO-Internal, WPI Data, PAJ

C. DOCUMENTS CONSIDERED TO BE RELEVANT

Category	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
X	US 5 868 850 A (ICHISHIMA ET AL.) 9 February 1999 (1999-02-09) the whole document	1,6,7, 11,12
Y	---	13-18
Y	PATENT ABSTRACTS OF JAPAN vol. 012, no. 362 (E-663), 28 September 1988 (1988-09-28) -& JP 63 116419 A (NEC CORP), 20 May 1988 (1988-05-20) abstract	13-18
A	---	1
X	US 5 904 872 A (ARAMI ET AL.) 18 May 1999 (1999-05-18) abstract; figures 9,13 column 8, line 11-19	1-3,6-8
A	---	16
	-/-	

Further documents are listed in the continuation of box C.

Patent family members are listed in annex.

* Special categories of cited documents :

- *A* document defining the general state of the art which is not considered to be of particular relevance
- *E* earlier document but published on or after the international filing date
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- *X* document of particular relevance; the claimed invention cannot be considered novel or cannot be considered to involve an inventive step when the document is taken alone
- *Y* document of particular relevance; the claimed invention cannot be considered to involve an inventive step when the document is combined with one or more other such documents, such combination being obvious to a person skilled in the art.
- *&* document member of the same patent family

Date of the actual completion of the international search

11 January 2001

Date of mailing of the international search report

26.01.01

Name and mailing address of the ISA

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INTERNATIONAL SEARCH REPORT

Inter	inal Application No
PCT/US 00/16635	

C.(Continuation) DOCUMENTS CONSIDERED TO BE RELEVANT		
Category	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
X	PATENT ABSTRACTS OF JAPAN vol. 014, no. 112 (E-0897), 28 February 1990 (1990-02-28) -& JP 01 310555 A (MITSUBISHI ELECTRIC CORP), 14 December 1989 (1989-12-14) abstract; figure 1 ----	20
A	EP 0 467 397 A (TOKYO ELECTRON LIMITED) 22 January 1992 (1992-01-22) abstract; figure 4 column 4, line 23-34 column 5, line 31-38 ----	1,2,6
A	PATENT ABSTRACTS OF JAPAN vol. 013, no. 078 (E-718), 22 February 1989 (1989-02-22) -& JP 63 260146 A (NIPPON MAIKURONIKUSU:KK), 27 October 1988 (1988-10-27) abstract ----	1
A	WO 99 03135 A (APPLIED MATERIALS) 21 January 1999 (1999-01-21) abstract; figure 2 ----	20
A	PATENT ABSTRACTS OF JAPAN vol. 016, no. 110 (C-0920), 18 March 1992 (1992-03-18) -& JP 03 285068 A (SONY CORP), 16 December 1991 (1991-12-16) abstract; figure 1 ----	20
A	PATENT ABSTRACTS OF JAPAN vol. 009, no. 277 (E-355), 6 November 1985 (1985-11-06) -& JP 60 119711 A (HITACHI SEISAKUSHO KK), 27 June 1985 (1985-06-27) abstract ----	20

INTERNATIONAL SEARCH REPORT

I. national application No.
PCT/US 00/16635

Box I Observations where certain claims were found unsearchable (Continuation of item 1 of first sheet)

This International Search Report has not been established in respect of certain claims under Article 17(2)(a) for the following reasons:

1. Claims Nos.: because they relate to subject matter not required to be searched by this Authority, namely:

2. Claims Nos.: because they relate to parts of the International Application that do not comply with the prescribed requirements to such an extent that no meaningful International Search can be carried out, specifically:

3. Claims Nos.: because they are dependent claims and are not drafted in accordance with the second and third sentences of Rule 6.4(a).

Box II Observations where unity of invention is lacking (Continuation of item 2 of first sheet)

This International Searching Authority found multiple inventions in this international application, as follows:

see additional sheet

1. As all required additional search fees were timely paid by the applicant, this International Search Report covers all searchable claims.

2. As all searchable claims could be searched without effort justifying an additional fee, this Authority did not invite payment of any additional fee.

3. As only some of the required additional search fees were timely paid by the applicant, this International Search Report covers only those claims for which fees were paid, specifically claims Nos.:

4. No required additional search fees were timely paid by the applicant. Consequently, this International Search Report is restricted to the invention first mentioned in the claims; it is covered by claims Nos.:

Remark on Protest

The additional search fees were accompanied by the applicant's protest.

No protest accompanied the payment of additional search fees.

FURTHER INFORMATION CONTINUED FROM PCT/ISA/ 210

This International Searching Authority found multiple (groups of) inventions in this international application, as follows:

1. Claims: 1-19

Process chamber assembly with reflective hot plate

2. Claims: 20-44

Process chamber assembly with pivoting lid

INTERNATIONAL SEARCH REPORT

Information on patent family members

Internatinal Application No

PCT/US 00/16635

Patent document cited in search report	Publication date	Patent family member(s)		Publication date
US 5868850	A 09-02-1999	DE 19622322	A 19-12-1996	
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JP 63116419	A 20-05-1988	JP 2077035	C 09-08-1996	
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